



ALPHA & OMEGA
SEMICONDUCTOR

AOD472

N-Channel Enhancement Mode Field Effect Transistor

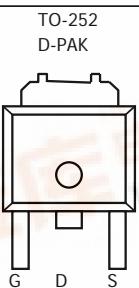


General Description

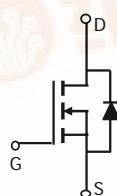
The AOD472 uses advanced trench technology and design to provide excellent $R_{DS(ON)}$ with low gate charge. This device is suitable for use in PWM, load switching and general purpose applications. Standard product AOD472 is Pb-free (meets ROHS & Sony 259 specifications). AOD472L is a Green Product ordering option. AOD472 and AOD472L are electrically identical.

Features

$V_{DS} (V) = 25V$
 $I_D = 50A (V_{GS} = 10V)$
 $R_{DS(ON)} < 6 m\Omega (V_{GS} = 10V)$
 $R_{DS(ON)} < 9.5 m\Omega (V_{GS} = 4.5V)$



Top View
Drain Connected to Tab



Absolute Maximum Ratings $T_A=25^\circ C$ unless otherwise noted

Parameter	Symbol	Maximum	Units
Drain-Source Voltage	V_{DS}	25	V
Gate-Source Voltage	V_{GS}	± 20	V
Continuous Drain Current ^G $T_C=25^\circ C$	I_D	50	A
	I_D	50	
Pulsed Drain Current ^C	I_{DM}	150	
Avalanche Current ^C	I_{AR}	30	A
Repetitive avalanche energy $L=0.3mH$ ^C	E_{AR}	135	mJ
Power Dissipation ^B $T_C=25^\circ C$	P_D	50	W
	P_D	25	
Power Dissipation ^A $T_A=25^\circ C$	P_{DSM}	3	W
	P_{DSM}	2.1	
Junction and Storage Temperature Range	T_J, T_{STG}	-55 to 175	°C

Thermal Characteristics

Parameter	Symbol	Typ	Max	Units
Maximum Junction-to-Ambient ^A $t \leq 10s$	R_{0JA}	15	20	°C/W
		41	50	°C/W
Maximum Junction-to-Case ^B	R_{0JC}	2.1	3	°C/W

Electrical Characteristics ($T_J=25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
STATIC PARAMETERS						
BV_{DSS}	Drain-Source Breakdown Voltage	$I_D=250\mu\text{A}, V_{GS}=0\text{V}$	25			V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS}=20\text{V}, V_{GS}=0\text{V}$ $T_J=55^\circ\text{C}$		1	5	μA
I_{GSS}	Gate-Body leakage current	$V_{DS}=0\text{V}, V_{GS}=\pm20\text{V}$		100		nA
$V_{\text{GS(th)}}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=250\mu\text{A}$	1	1.4	2.5	V
$I_{\text{D(ON)}}$	On state drain current	$V_{GS}=10\text{V}, V_{DS}=5\text{V}$	150			A
$R_{\text{DS(ON)}}$	Static Drain-Source On-Resistance	$V_{GS}=10\text{V}, I_D=30\text{A}$		5	6	$\text{m}\Omega$
			$T_J=125^\circ\text{C}$	7.5		
		$V_{GS}=4.5\text{V}, I_D=20\text{A}$		7.6	9.5	
g_{FS}	Forward Transconductance	$V_{DS}=5\text{V}, I_D=20\text{A}$	49			S
V_{SD}	Diode Forward Voltage	$I_S=1\text{A}, V_{GS}=0\text{V}$	0.74	1		V
I_S	Maximum Body-Diode Continuous Current			50		A
DYNAMIC PARAMETERS						
C_{iss}	Input Capacitance	$V_{GS}=0\text{V}, V_{DS}=12.5\text{V}, f=1\text{MHz}$		2050	2460	pF
C_{oss}	Output Capacitance			485		pF
C_{rss}	Reverse Transfer Capacitance			280		pF
R_g	Gate resistance	$V_{GS}=0\text{V}, V_{DS}=0\text{V}, f=1\text{MHz}$		0.86	1.5	Ω
SWITCHING PARAMETERS						
$Q_g(10\text{V})$	Total Gate Charge	$V_{GS}=10\text{V}, V_{DS}=12.5\text{V}, I_D=20\text{A}$		34	41	nC
$Q_g(4.5\text{V})$	Total Gate Charge			17	22	nC
Q_{gs}	Gate Source Charge			5		nC
Q_{gd}	Gate Drain Charge			3.5		nC
$t_{\text{D(on)}}$	Turn-On Delay Time	$V_{GS}=10\text{V}, V_{DS}=12.5\text{V}, R_L=0.68\Omega, R_{\text{GEN}}=3\Omega$		7.5		ns
t_r	Turn-On Rise Time			11		ns
$t_{\text{D(off)}}$	Turn-Off Delay Time			27		ns
t_f	Turn-Off Fall Time			8		ns
t_{rr}	Body Diode Reverse Recovery Time	$I_F=20\text{A}, dI/dt=100\text{A}/\mu\text{s}$		30	36	ns
Q_{rr}	Body Diode Reverse Recovery Charge	$I_F=20\text{A}, dI/dt=100\text{A}/\mu\text{s}$		19		nC

A: The value of R_{JJA} is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^\circ\text{C}$. The Power dissipation P_{DSM} is based on R_{JJA} and the maximum allowed junction temperature of 150°C . The value in any given application depends on the user's specific board design, and the maximum temperature of 175°C may be used if the PCB allows it.

B. The power dissipation P_D is based on $T_{J(\text{MAX})}=175^\circ\text{C}$, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C: Repetitive rating, pulse width limited by junction temperature $T_{J(\text{MAX})}=175^\circ\text{C}$.

D. The R_{JJA} is the sum of the thermal impedance from junction to case R_{JJC} and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300 μs pulses, duty cycle 0.5% max.

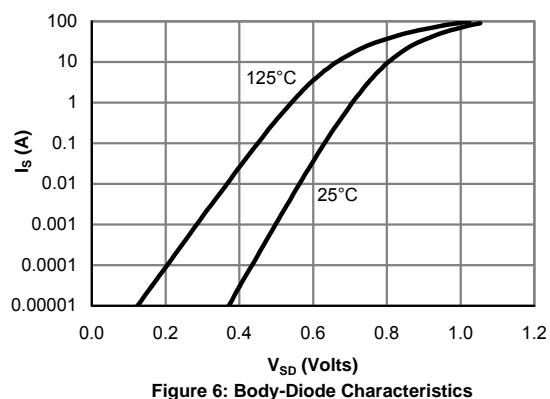
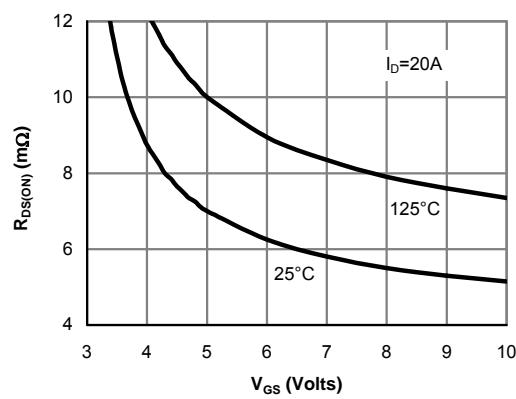
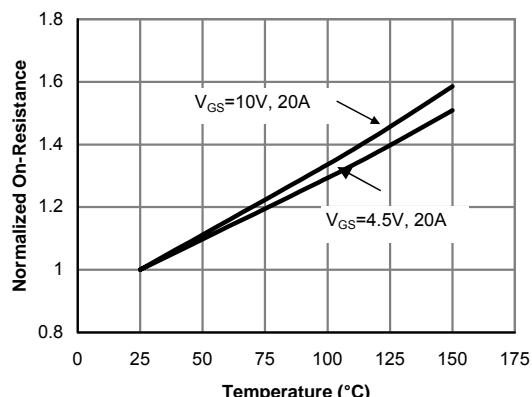
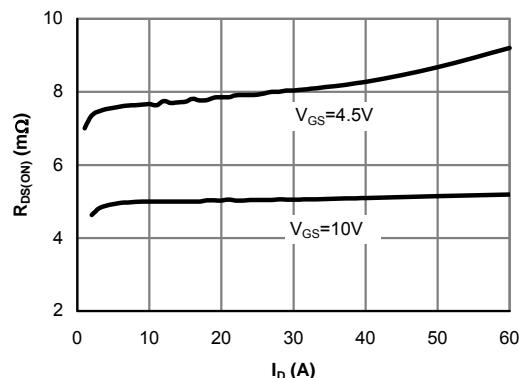
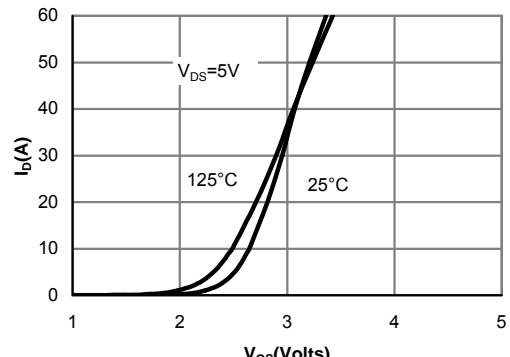
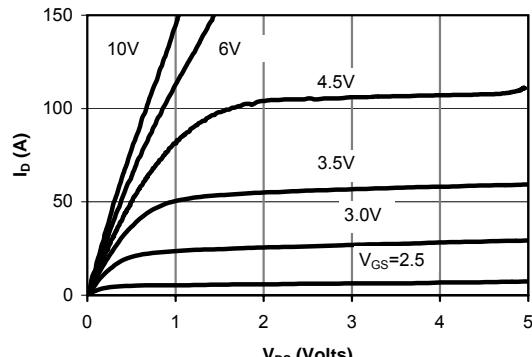
F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of $T_{J(\text{MAX})}=175^\circ\text{C}$.

G. The maximum current rating is limited by bond-wires.

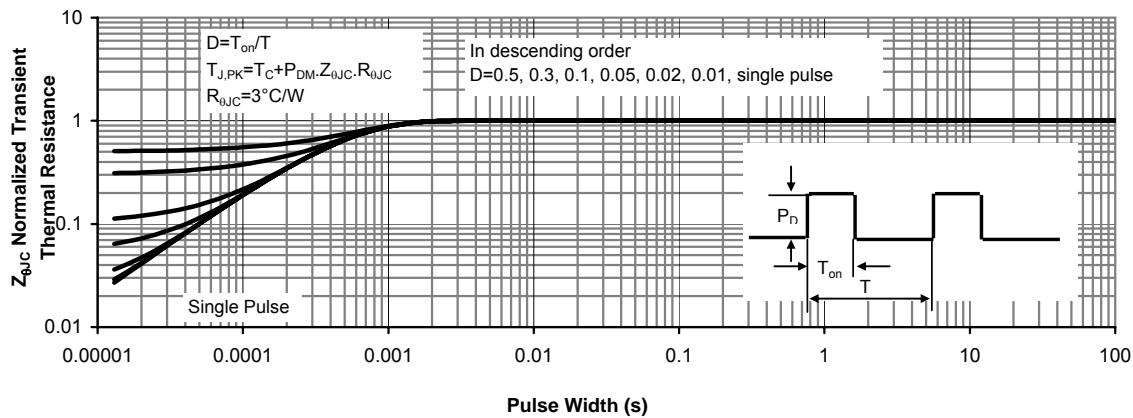
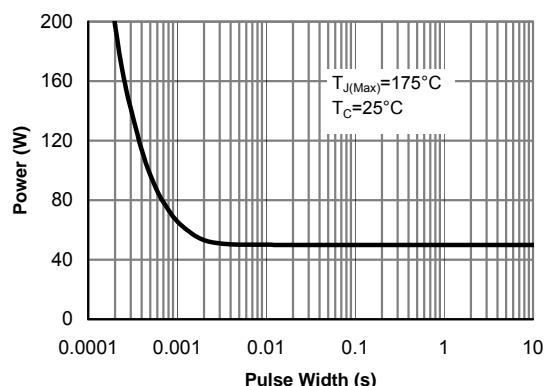
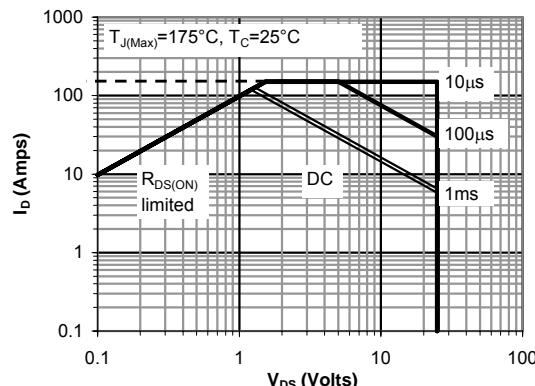
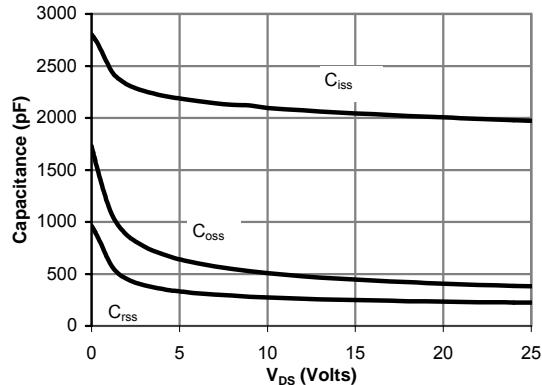
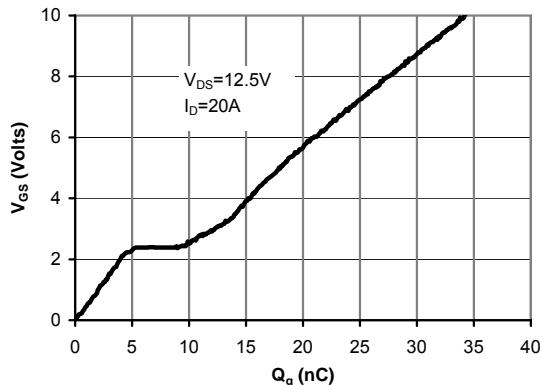
H. These tests are performed with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^\circ\text{C}$. The SOA curve provides a single pulse rating. Rev1: March 2006

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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



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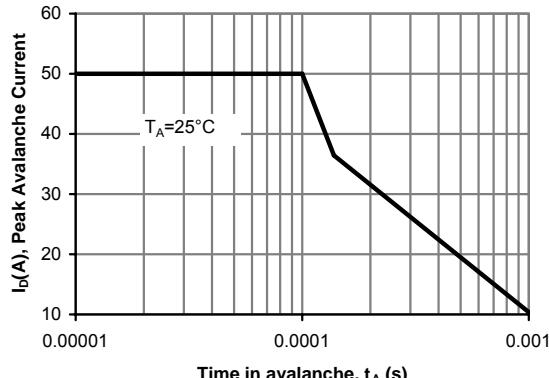
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

Figure 12: Single Pulse Avalanche capability

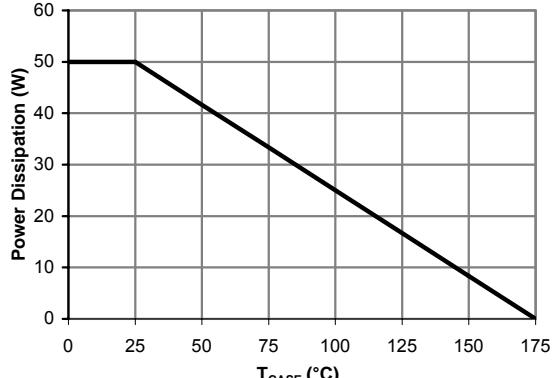


Figure 13: Power De-rating (Note B)

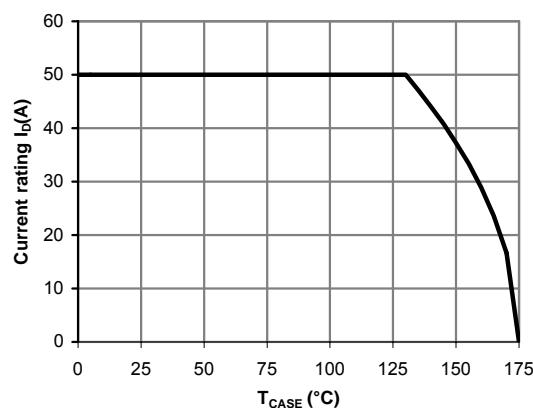


Figure 14: Current De-rating (Note B)

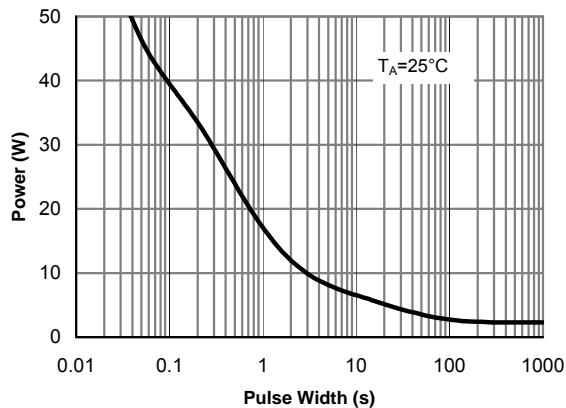


Figure 15: Single Pulse Power Rating Junction-to-Ambient (Note H)

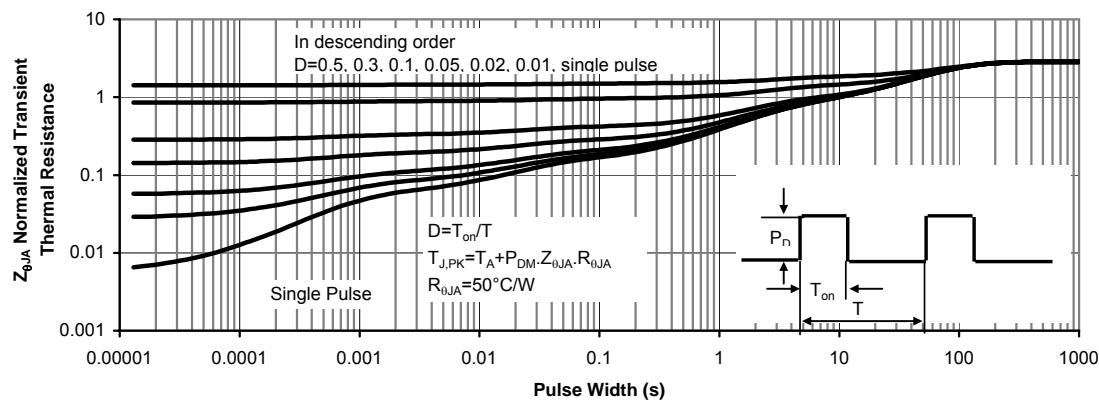


Figure 16: Normalized Maximum Transient Thermal Impedance (Note H)



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